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Sheet 1 of 1

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APPLICANT NAOJI OTSUKA, ET AL.

FILING DATE September 29, 2000

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288

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>U</i>	4,723,129	2/2/88	Endo et al.	346	1.1	
	4,740,796	4/26/88	Endo et al.	346	1.1	
	4,463,359	7/31/84	Ayata et al.	346	1.1	
	4,345,262	8/17/82	Shirato et al.	346	140	
	4,313,124	1/29/82	Hara	346	140	
	4,558,333	12/10/85	Sugitani et al.	346	140	
<i>C</i>	4,459,600	7/10/84	Sato et al.	346	140	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>U</i>	59-123670	7/17/84	Japan	—	—	Abstract
	84-138461	8/8/84	Japan	—	—	Abstract
	79-56847	5/8/79	Japan	—	—	Abstract
<i>C</i>	85-71260	4/23/85	Japan	—	—	Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER		DATE CONSIDERED	7/11/01

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